

PowerMOS transistor

BUK444-400B

GENERAL DESCRIPTION

N-channel enhancement mode field-effect power transistor in a plastic full-pack envelope. The device is intended for use in Switched Mode Power Supplies (SMPS), motor control, welding, DC/DC and AC/DC converters, and in general purpose switching applications.

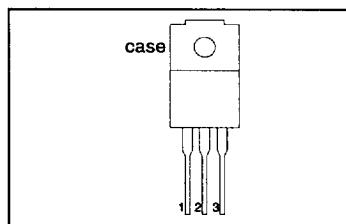
QUICK REFERENCE DATA

| SYMBOL | PARAMETER | MAX. | UNIT |
|--------------|----------------------------------|------|----------|
| V_{DS} | Drain-source voltage | 400 | V |
| I_D | Drain current (DC) | 2.4 | A |
| P_{tot} | Total power dissipation | 25 | W |
| $R_{DS(on)}$ | Drain-source on-state resistance | 1.8 | Ω |

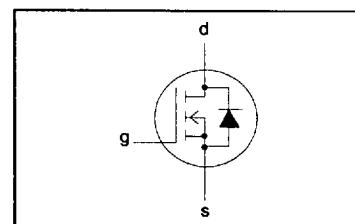
PINNING - SOT186

| PIN | DESCRIPTION |
|------|-------------|
| 1 | gate |
| 2 | drain |
| 3 | source |
| case | isolated |

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|--------------|----------------------------------|-------------------------------|------|------|------|
| V_{DS} | Drain-source voltage | - | - | 400 | V |
| V_{DGR} | Drain-gate voltage | $R_{GS} = 20 \text{ k}\Omega$ | - | 400 | V |
| $\pm V_{GS}$ | Gate-source voltage | - | - | 30 | V |
| I_D | Drain current (DC) | $T_{hs} = 25^\circ\text{C}$ | - | 2.4 | A |
| I_D | Drain current (DC) | $T_{hs} = 100^\circ\text{C}$ | - | 1.5 | A |
| I_{DM} | Drain current (pulse peak value) | $T_{hs} = 25^\circ\text{C}$ | - | 9.6 | A |
| P_{tot} | Total power dissipation | $T_{hs} = 25^\circ\text{C}$ | - | 25 | W |
| T_{stg} | Storage temperature | - | -55 | 150 | °C |
| T_j | Junction Temperature | - | - | 150 | °C |

THERMAL RESISTANCES

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|----------------|---|------------------------|------|------|------|------|
| $R_{th(j-hs)}$ | Thermal resistance junction to heatsink | with heatsink compound | - | - | 5 | K/W |
| $R_{th(j-a)}$ | Thermal resistance junction to ambient | | - | 55 | - | K/W |

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STATIC CHARACTERISTICS $T_{hs} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|----------------------------------|---|------|------|------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}$ | 400 | - | - | V |
| $V_{GS(TO)}$ | Gate threshold voltage | $V_{DS} = V_{GS}; I_D = 1 \text{ mA}$ | 2.1 | 3.0 | 4.0 | V |
| I_{DSS} | Zero gate voltage drain current | $V_{DS} = 400 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$ | - | 2 | 20 | μA |
| I_{DSS} | Zero gate voltage drain current | $V_{DS} = 400 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125^\circ\text{C}$ | - | 0.1 | 1.0 | mA |
| I_{GSS} | Gate source leakage current | $V_{GS} = \pm 30 \text{ V}; V_{DS} = 0 \text{ V}$ | - | 10 | 100 | nA |
| $R_{DS(ON)}$ | Drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 1.5 \text{ A}$ | - | 1.6 | 1.8 | Ω |

DYNAMIC CHARACTERISTICS $T_{hs} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|----------------------------|--|------|------|------|------|
| g_f | Forward transconductance | $V_{DS} = 25 \text{ V}; I_D = 1.5 \text{ A}$ | 2.1 | 2.5 | - | S |
| C_{iss} | Input capacitance | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ | - | 360 | 500 | pF |
| C_{oss} | Output capacitance | | - | 60 | 80 | pF |
| C_{rss} | Feedback capacitance | | - | 25 | 60 | pF |
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 30 \text{ V}; I_D = 2.5 \text{ A}; V_{GS} = 10 \text{ V}; R_{GS} = 50 \Omega; R_{gen} = 50 \Omega$ | - | 15 | 20 | ns |
| t_r | Turn-on rise time | | - | 40 | 60 | ns |
| $t_{d(off)}$ | Turn-off delay time | | - | 50 | 65 | ns |
| t_f | Turn-off fall time | | - | 30 | 40 | ns |
| L_d | Internal drain inductance | Measured from drain lead 6 mm from package to centre of die | - | 4.5 | - | nH |
| L_s | Internal source inductance | Measured from source lead 6 mm from package to source bond pad | - | 7.5 | - | nH |

ISOLATION $T_{hs} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------|---|---|------|------|------|------|
| V_{isol} | Repetitive peak voltage from all three terminals to external heatsink | $R.H. \leq 65\%; \text{clean and dustfree}$ | - | - | 1500 | V |
| C_{isol} | Capacitance from T2 to external heatsink | $f = 1 \text{ MHz}$ | - | 12 | - | pF |

REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS $T_{hs} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|----------------------------------|--|------|------|------|---------------|
| I_{DR} | Continuous reverse drain current | - | - | - | 2.7 | A |
| I_{DRM} | Pulsed reverse drain current | - | - | - | 11 | A |
| V_{SD} | Diode forward voltage | $I_F = 2.7 \text{ A}; V_{GS} = 0 \text{ V}$ | - | 1.1 | 1.4 | V |
| t_r | Reverse recovery time | $I_F = 2.7 \text{ A}; -di_F/dt = 100 \text{ A}/\mu\text{s}; V_{GS} = 0 \text{ V}; V_R = 100 \text{ V}$ | - | 260 | - | ns |
| Q_r | Reverse recovery charge | | - | 2.5 | - | μC |

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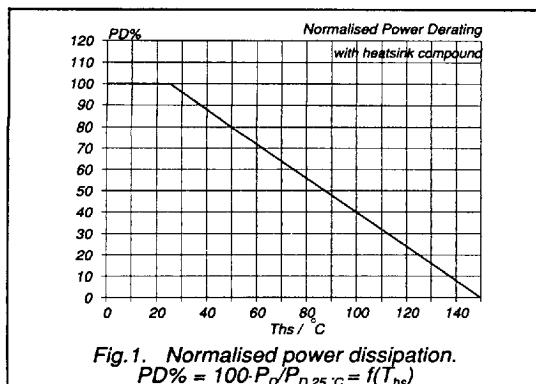


Fig. 1. Normalised power dissipation.
 $PD\% = 100 \cdot P_D / P_{D, 25^\circ C} = f(T_{hs})$

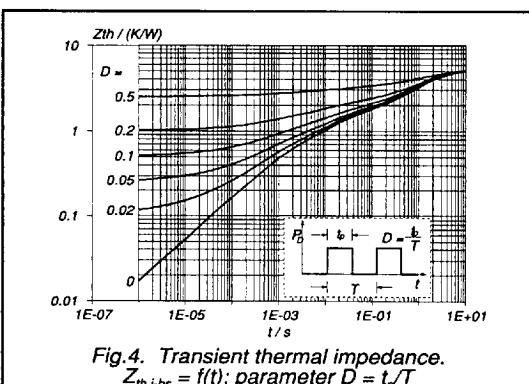


Fig. 4. Transient thermal impedance.
 $Z_{th(j-hs)} = f(t); \text{ parameter } D = t_p/T$

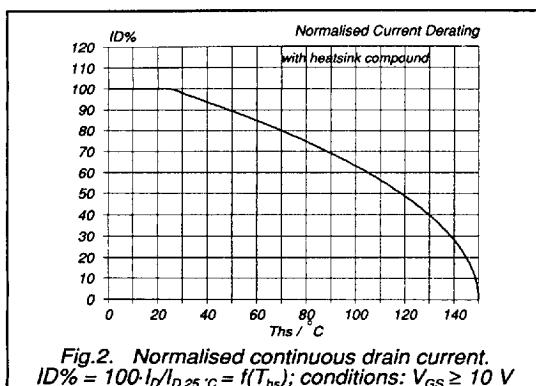


Fig. 2. Normalised continuous drain current.
 $ID\% = 100 \cdot I_D / I_{D, 25^\circ C} = f(T_{hs}); \text{ conditions: } V_{GS} \geq 10 \text{ V}$

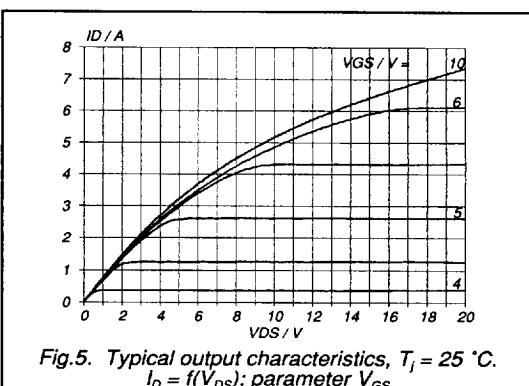


Fig. 5. Typical output characteristics, T_j = 25 °C.
 $I_D = f(V_{DS}); \text{ parameter } V_{GS}$

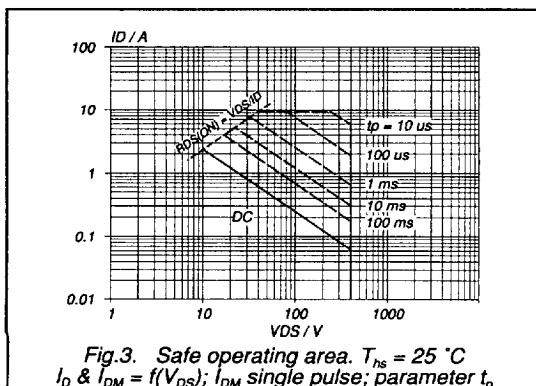


Fig. 3. Safe operating area. T_{hs} = 25 °C
 $I_D \text{ & } I_{DM} = f(V_{DS}); I_{DM} \text{ single pulse; parameter } t_p$

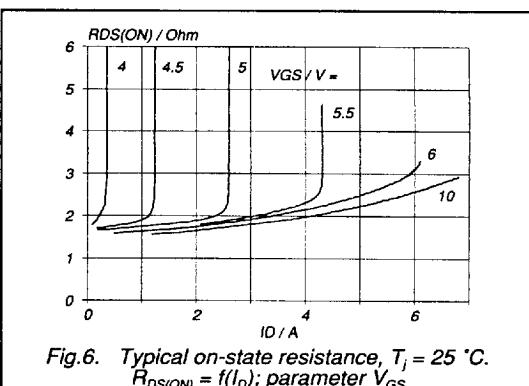


Fig. 6. Typical on-state resistance, T_j = 25 °C.
 $R_{DS(ON)} = f(I_D); \text{ parameter } V_{GS}$

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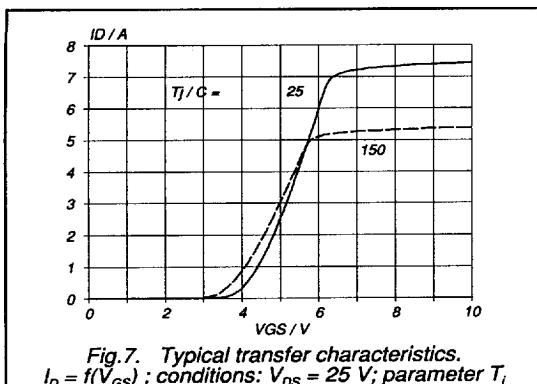


Fig.7. Typical transfer characteristics.
 $I_D = f(V_{GS})$; conditions: $V_{DS} = 25\text{ V}$; parameter T_J

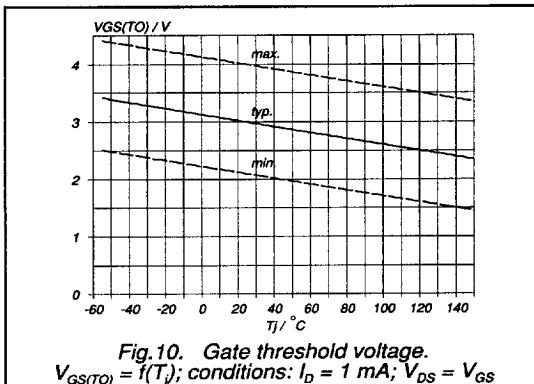


Fig.10. Gate threshold voltage.
 $V_{GS(TH)} = f(T_J)$; conditions: $I_D = 1\text{ mA}$; $V_{DS} = V_{GS}$

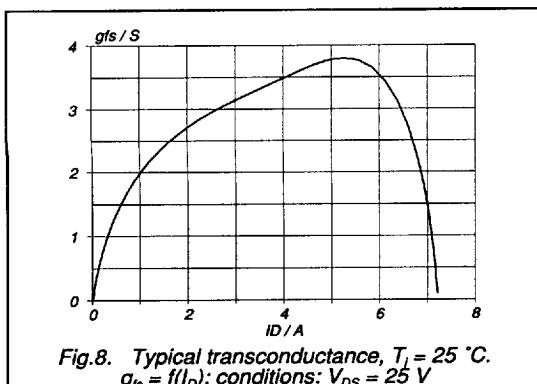


Fig.8. Typical transconductance, $T_J = 25^\circ\text{C}$.
 $g_{fs} = f(I_D)$; conditions: $V_{DS} = 25\text{ V}$

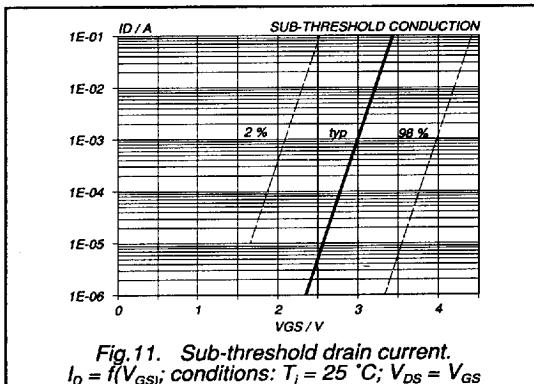


Fig.11. Sub-threshold drain current.
 $I_D = f(V_{GS})$; conditions: $T_J = 25^\circ\text{C}$; $V_{DS} = V_{GS}$

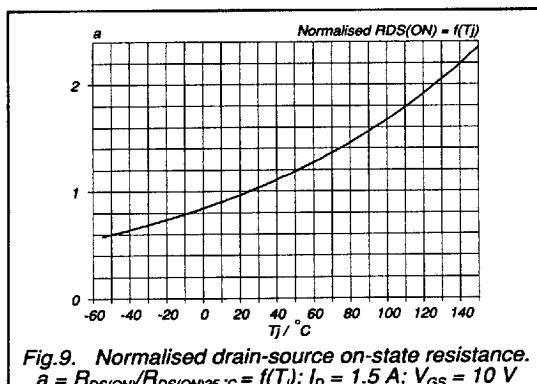


Fig.9. Normalised drain-source on-state resistance.
 $a = R_{DS(ON)}/R_{DS(ON)25^\circ\text{C}} = f(T_J)$; $I_D = 1.5\text{ A}$; $V_{GS} = 10\text{ V}$

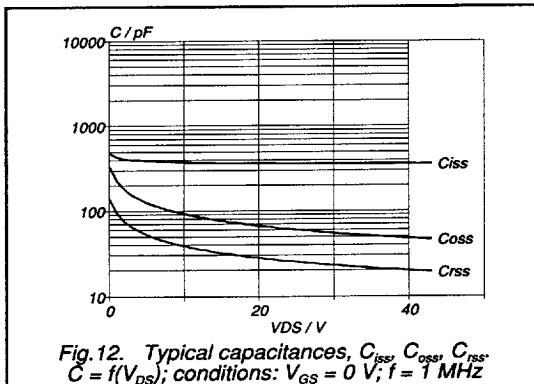


Fig.12. Typical capacitances, C_{iss} , C_{oss} , C_{rss} .
 $C = f(V_{DS})$; conditions: $V_{GS} = 0\text{ V}$; $f = 1\text{ MHz}$

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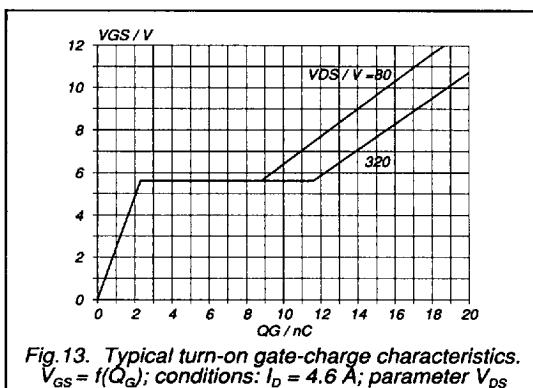


Fig.13. Typical turn-on gate-charge characteristics.
 $V_{GS} = f(Q_G)$; conditions: $I_D = 4.6 \text{ A}$; parameter V_{DS}

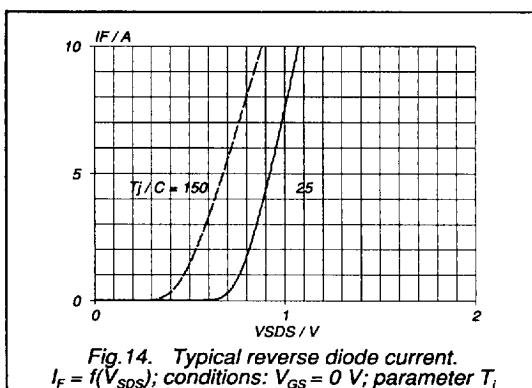


Fig.14. Typical reverse diode current.
 $I_F = f(V_{SDS})$; conditions: $V_{GS} = 0 \text{ V}$; parameter T_j